

3.3V CMOS Low Jitter XO

FD

Actual Size = 5 x 3.2mm



Product Features

- Less than 1.5 ps RMS jitter with fundamental or overtone design
- 3.3V CMOS/TTL compatible logic levels
- Pin-compatible with standard 3.2x5mm packages
- Designed for standard reflow and washing techniques
- Low power standby mode
- Pb-free and RoHS/Green compliant

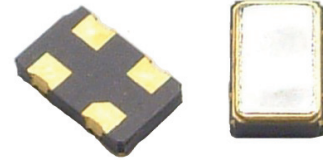
Product Description

The FD Series includes a 3.3V crystal clock oscillator that achieves superb jitter and stability over a broad range of operating conditions and frequencies. The output clock signal, generated internally with a non-PLL oscillator design, is compatible with LVCMOS/LVTTL logic levels. The device, available on tape and reel, is contained in a 5x3.2mm surface-mount ceramic package.

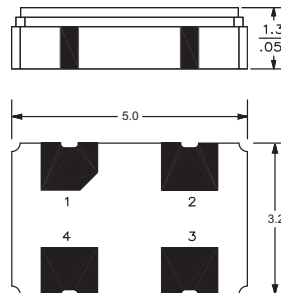
Applications

The FD Series is an ideal reference clock for compact, high-density applications requiring low jitter or tight stability, including:

- Ethernet
- FibreChannel
- Serial Attached SCSI (SAS)
- Server & Storage platforms
- SONET/SDH linecards
- T1/E1, T3/E3 linecards
- DSLAM
- 802.11a/b/g WiFi



Packaging Outline



Pin Functions

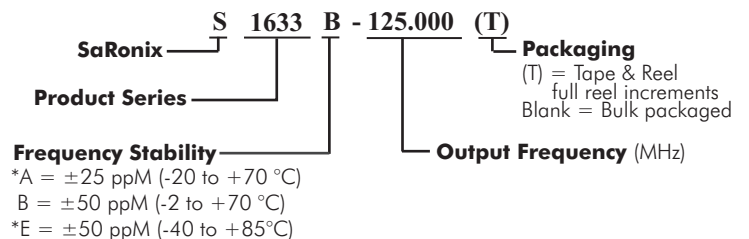
Pin	Function
1	OE Function
2	Ground
3	Clock Output
4	V _{DD}

New Part Number Example

FD **C50** **0001** A = Product Family
 ⓐ ⓑ ⓒ B = Frequency Code
 C = Specification Code

Note: After July 1, 2007, a Saronix - eCera part number following the above format will be assigned upon confirmation of exact customer requirements.

Legacy Ordering Information (for reference only)



* Availability varies by frequency.

Electrical Performance

Parameter	Min.	Typ.	Max.	Units	Notes
Output frequency	1.8432		125	MHz	As specified
Supply voltage	+3.135	+3.3	+3.465	V	
Supply current, output enabled			15	mA	1.8432 to <40 MHz
			12		40 to 50 MHz
			25		>50 to <60 MHz
			40		60 to <80 MHz
			55	mA	80 to 125 MHz
Supply current, standby mode			10	μA	Output Hi-Z
Frequency stability			±25 to ±50	ppM	See Note 1 below
Operating temperature	-40		+85	°C	As specified
Output logic 0, VOL			10% V _{DD}	V	
Output logic 1, VOH	90% V _{DD}			V	
Output load	15 pF (max) or 10 LSTTL				
Duty cycle (1.8432 to 79.9999 MHz)	45		55	%	-40 to +85°C measured 50%VDD
Duty cycle (80 to 125 MHz)	45		55	%	-20 to +70°C measured 50%VDD
Duty cycle (80 to 125 MHz)	40		60	%	-40 to +85°C measured 50%VDD
Rise and fall time	<40 MHz		7	ns	measured 20/80% of waveform
	40 to <80 MHz		5		
	80 to 125 MHz		3		
Jitter, Phase	up to <80 MHz		1.5	ps RMS (1-σ)	10kHz to 20 MHz frequency band
	80 to 125 MHz		1		
Jitter, Accumulated	up to <80 MHz		5	ps RMS (1-σ)	20.000 adjacent periods
	80 to 125 MHz		3		
Jitter, Total	up to <80 MHz		50	ps pk-pk	100.000 random periods
	80 to 125 MHz		30		

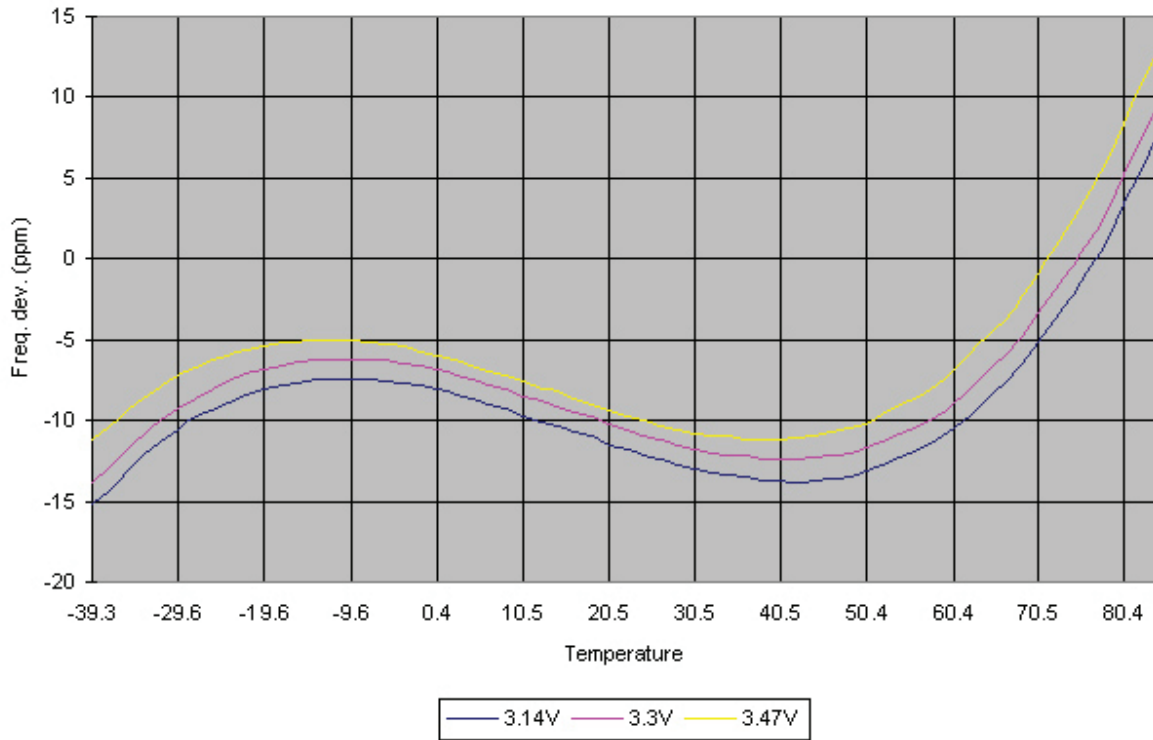
Notes:

- As specified. Stability includes all combinations of operating temperature, load changes, rated input (supply) voltage changes, initial calibration tolerance (25°C), aging (1 year at 25°C average effective ambient temperature), shock and vibration.
- For specifications other than those listed, please contact sales.

Output Enable / Disable Function

Parameter	Min.	Typ.	Max.	Units	Notes
Input Voltage (pin 1), Output Enable	2.2			V	or open
Input voltage (pin 1), Output Disable (low power standby)			0.8	V	Output is Hi-Z
Internal pullup resistance	50			kΩ	
Output disable delay			100	ns	
Output enable delay			10	ms	

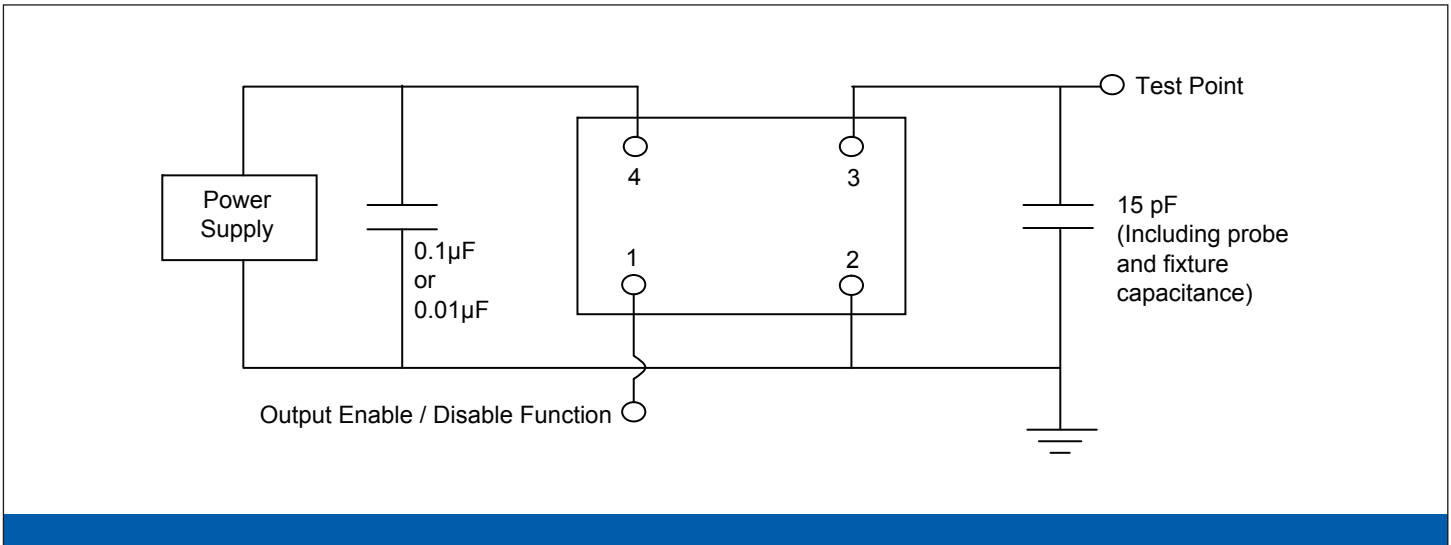
Temperature WaveForm



Absolute Maximum Ratings

Parameter	Min.	Typ.	Max.	Units	Notes
Storage temperature	-55		+125	°C	

Test Circuit

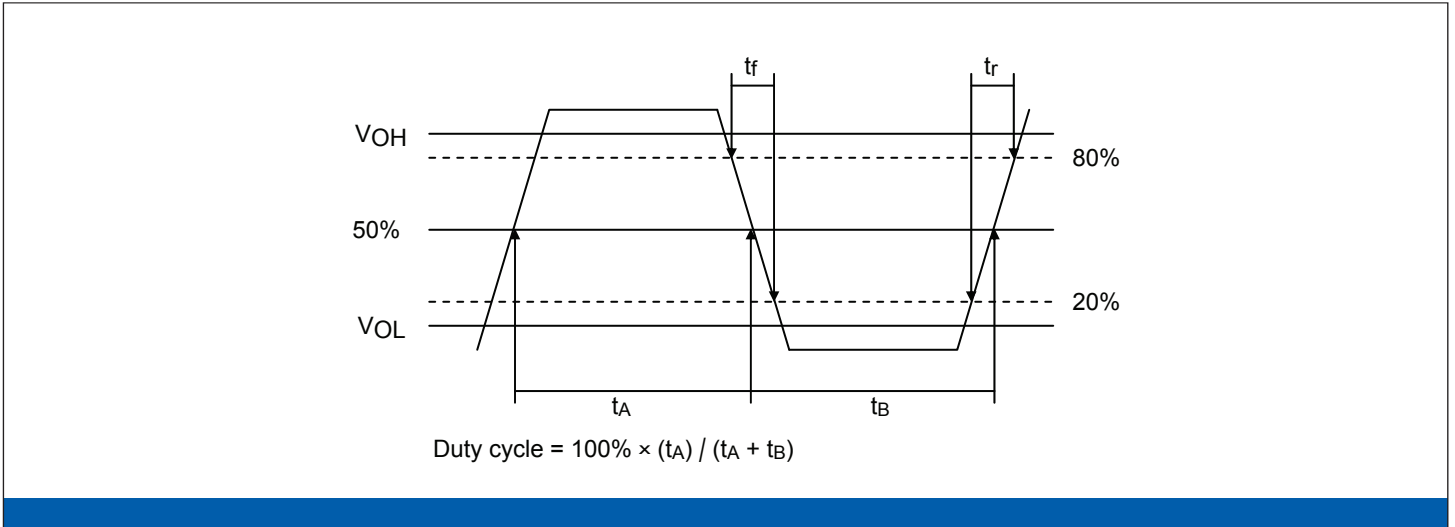


Reliability Test Ratings

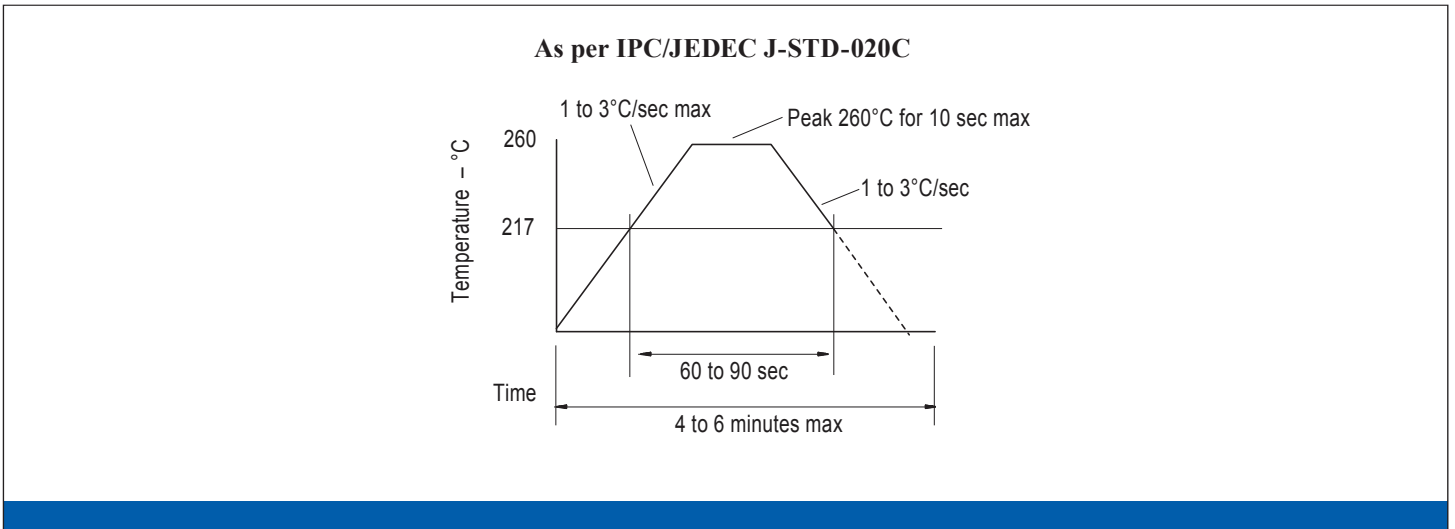
This product is rated to meet the following test conditions:

Type	Parameter	Test Condition
Mechanical	Shock	MIL-STD-883, Method 2002, Condition B
Mechanical	Solderability	JESD22-B102-D Method 2 (Preconditioning E)
Mechanical	Terminal strength	MIL-STD-883, Method 2004, Condition D
Mechanical	Gross leak	MIL-STD-883, Method 1014, Condition C
Mechanical	Fine leak	MIL-STD-883, Method 1014, Condition A2 ($R_1 = 2 \times 10^{-8}$ atm cc/s)
Mechanical	Solvent resistance	MIL-STD-202, Method 215
Environmental	Thermal shock	MIL-STD-883, Method 1011, Condition A
Environmental	Moisture resistance	MIL-STD-883, Method 1004
Environmental	Vibration	MIL-STD-883, Method 2007, Condition A
Environmental	Resistance to soldering heat	J-STD-020C Table 5-2 Pb-free devices (2 cycles max)

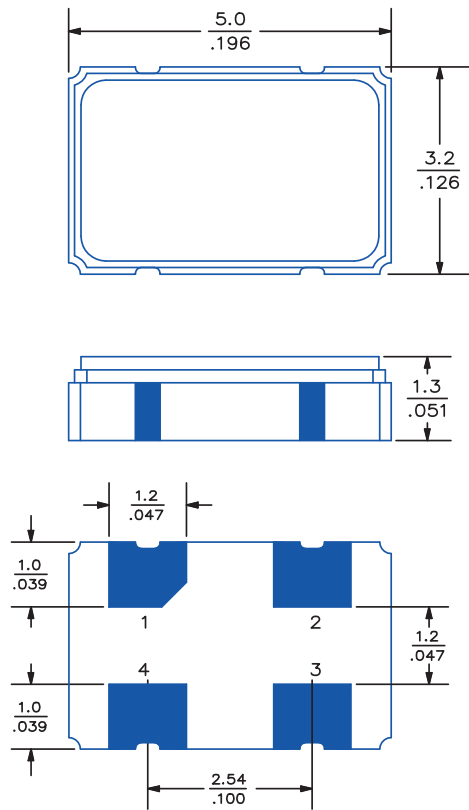
Output Waveform



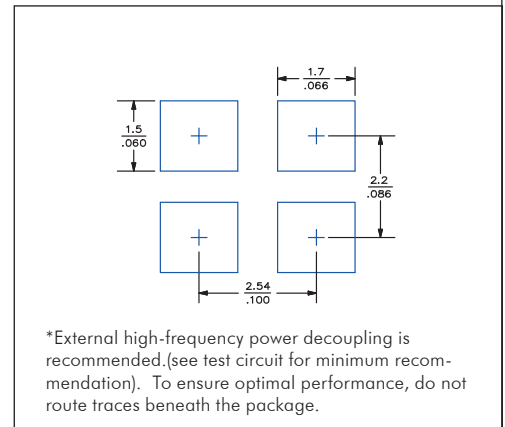
Reflow Soldering Profile



Mechanical Drawings



Recommended Land Pattern*



Scale: None. Dimensions are in mm/inches.